

Notice of References Cited	Application/Control No. 10/587,577		Applicant(s)/Patent Under Reexamination SONETAKA, NORIYOSHI	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,877,947 A	10-1989	Mori, Toru	235/380
*	B	US-5,286,954 A	02-1994	Sato et al.	235/379
*	C	US-2001/0011249 A1	08-2001	YANAGIHARA et al.	705/41
*	D	US-2002/0086704 A1	07-2002	Meindl et al.	455/558
*	E	US-2002/0125311 A1	09-2002	Ijichi et al.	235/380
*	F	US-2003/0006280 A1	01-2003	Seita et al.	235/380
*	G	US-2003/0085288 A1	05-2003	Luu, Deniel V.H.	235/492
*	H	US-2004/0054632 A1	03-2004	Remy, Cedric	705/064
*	I	US-2004/0065734 A1	04-2004	Piikivi, Lauri	235/451
*	J	US-2004/0098625 A1	05-2004	Lagadec et al.	713/201
*	K	US-6,776,339 B2	08-2004	Piikivi, Lauri	235/451
*	L	US-2005/0287987 A1	12-2005	Yamamoto, Hikaru	455/410
*	M	US-2006/0049258 A1	03-2006	Piikivi, Lauri	235/451

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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Notice of References Cited	Application/Control No. 10/587,577		Applicant(s)/Patent Under Reexamination SONETAKA, NORIYOSHI	
	Examiner DANIEL WALSH		Art Unit 2887	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0063565 A1	03-2006	Ueno, Mitsuhiro	455/558
*	B	US-2007/0158402 A1	07-2007	Sonetaka, Noriyoshi	235/375
*	C	US-2007/0162381 A1	07-2007	Petralia et al.	705/038
*	D	US-2007/0186107 A1	08-2007	Sonetaka, Noriyoshi	713/170
*	E	US-2007/0191057 A1	08-2007	Kamada, Tomihisa	455/558
*	F	US-2007/0213096 A1	09-2007	Bella et al.	455/558
*	G	US-2007/0293155 A1	12-2007	Liao et al.	455/41.2
*	H	US-2008/0020755 A1	01-2008	Liu et al.	455/432.1
*	I	US-2008/0076475 A1	03-2008	KIM, Yong-Wook	455/558
*	J	US-2009/0029763 A1	01-2009	Schwartz, Andrew J.	463/25
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

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